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FORM PTO/SB/08A/B (10-01) Substitute for PTO-1449A/B	DEC 2	4 2002
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STATEMENT BY APPLICANT

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Attorney Docket Number	47489/JWP/C766
Application Number	10/052,302
Filing Date	January 18, 2002
Applicant(s)	Brian D. Hunt, et al.
Group Art Unit	2834
Examiner Name	to be assigned

U.S. PATENT DOCUMENTS						
EXAMINER INITIALS	Cite No.1	DOCUMENT NUMBER Number - kind code <sup>†</sup> - (If known)	PUBLICATION DATE MM-DD-YYYY	NAME OF PATENTEE		

FOREIGN PATENT DOCUMENTS					
EXAMINER INITIALS	Cite No.	Foreign Patent Document Country Code <sup>8</sup> - Number <sup>4</sup> - Kind Code <sup>5</sup> (If known)	Publication Date  MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T <sup>6</sup> (✔)
25		WO 02/093738 A2	11-21-2002	California Institute of Technology	

OTHER DOCUMENTS					
EXAMINER Cite Include name of the author (in CAPITAL LETTERS), title of the article, title of the item (book, magazine, journal, serial symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					

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JUN 2 8 2002	Application Number	10/052,302
INFORMATION DESCLOSURE	Filing Date	January 18, 2002
STATEMENT BY APPLICANT	Applicant(s)	Brian D. Hunt cal.
	Group Art Unit	2834
(use as many sheets as necessary)	Examiner Name	to be assigned to

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JUN 2 8 ZULZ	Application Number	10/052,302
INFORMATION DESCLOSURE	Filing Date	January 18, 2002
STATEMENT BY APPLICANT	Applicant(s)	Brian D. Hunt
	Group Art Unit	2834
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Attorney Docket Number	47489/JWP/C766
Application Number	10/052,302
Filing Date	January 18, 2002
Applicant(s)	Brian D. Hunt
Group Art Unit	2834 SEP - V
Examiner Name	to be assigned 9 2002

		OTHER DOCUMENTS
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Attorney Docket Number	47489/JWP/C79
Application Number	10/052,302
Filing Date	January 18, 2002 0 含
Applicant(s)	Brian D. Hunt et al
Group Art Unit	2834 SEP
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		OTHER DOCUMENTS
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FORM PTO/SB/08A/B (10-01) Substitute for PTO-1449A/B	104 5 8 2005 A
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Attorney Docket Number	41285/JWP/C766	<b>b</b>
Application Number	09/791,493	
Filing Date	February 22, 2001	m
Applicant(s)	Flavio Noca et al.	0
Group Art Unit	1743 SED	VV
Examiner Name	to be assigned	

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